



Power MOSFETS

DATASHEET

LM40045NHP3A

N-Channel
Enhancement Mode MOSFET

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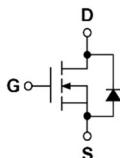
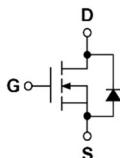


Quality Management Systems
ISO 9001:2015 Certificate

LM40045NHP3A

N-Channel Enhancement Mode MOSFET

Pin Description

| TO-220-3L (TOP view) | Symbol | Symbol | N-Channel | Unit | |
|---|---|---|-------------------------|------|------------------|
|  |  |  | V_{DSS} | 40 | V |
| | | | $R_{DS(ON)}\text{-Max}$ | 4.6 | $\text{m}\Omega$ |
| | | | I_D | 112 | A |

Feature

- Low R_{dson} ($V_{gs}=10\text{V}$)
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS Tested

Product Summary

Applications

- DC/DC Converters
- SMPS Synchronous Rectification

Ordering Information

| Orderable Part Number | Package Type | Form | Shipping | Marking |
|-----------------------|--------------|------|-----------|---|
| LM40045NHP3A | TO-220-3L | Tube | 50 / Tube | 40045 <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/> |

Note : = Lot Code

Absolute Maximum Ratings ($T_J=25^\circ\text{C}$ Unless Otherwise Noted)

| Symbol | Parameter | | N-Channel | Unit |
|-----------------------|---------------------------------|-------------------------|------------|------------------|
| V_{DSS} | Drain-Source Voltage | | 40 | V |
| V_{GSS} | Gate-Source Voltage | | ± 20 | |
| T_J | Maximum Junction Temperature | | 150 | $^\circ\text{C}$ |
| T_{STG} | Storage Temperature Range | | -55 to 150 | $^\circ\text{C}$ |
| $I_{DM}^{\text{(1)}}$ | Pulse Drain Current Tested | $T_c=25^\circ\text{C}$ | 184 | A |
| I_D | Continuous Drain Current | $T_c=25^\circ\text{C}$ | 112 | A |
| | | $T_c=100^\circ\text{C}$ | 71 | |
| P_D | Maximum Power Dissipation | $T_c=25^\circ\text{C}$ | 83 | W |
| | | $T_c=100^\circ\text{C}$ | 33 | |
| $I_{AS}^{\text{(2)}}$ | Avalanche Current, Single pulse | $L=0.1\text{mH}$ | 25 | A |
| $E_{AS}^{\text{(2)}}$ | Avalanche Energy, Single pulse | $L=0.1\text{mH}$ | 31 | mJ |

Thermal Characteristics

| Symbol | Parameter | | Rating | Unit |
|------------------------------|--|--------------|--------|--------------------|
| $R_{\theta JC}$ | Thermal Resistance-Junction to Case | Steady State | 1.5 | $^\circ\text{C/W}$ |
| $R_{\theta JA}^{\text{(3)}}$ | Thermal Resistance-Junction to Ambient | Steady State | 62.5 | $^\circ\text{C/W}$ |

Note ① : Max. current is limited by bonding wire

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in^2 FR-4 board with 1oz.

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N-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ Unless Otherwise Noted)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---|----------------------------------|--|------|------|-----------|------------------|
| Static Electrical Characteristics | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{\text{GS}}=0\text{V}$, $I_{\text{DS}}=250\mu\text{A}$ | 40 | - | - | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{\text{DS}}=32\text{V}$, $V_{\text{GS}}=0\text{V}$ | - | - | 1 | μA |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{DS}}=250\mu\text{A}$ | 2 | 2.8 | 4 | V |
| I_{GSS} | Gate Leakage Current | $V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$ | - | - | ± 100 | nA |
| $R_{\text{DS(ON)}}^{\circledast}$ | Drain-Source On-state Resistance | $V_{\text{GS}}=10\text{V}$, $I_{\text{DS}}=20\text{A}$ | - | 3.8 | 4.6 | $\text{m}\Omega$ |
| g_{fs} | Forward Transconductance | $V_{\text{DS}}=5\text{V}$, $I_{\text{DS}}=10\text{A}$ | - | 20 | - | S |
| Dynamic Characteristics ^④ | | | | | | |
| R_{G} | Gate Resistance | $V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}$, Freq.=1MHz | - | 2.9 | - | Ω |
| C_{iss} | Input Capacitance | $V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=20\text{V}$, Freq.=1MHz | - | 3185 | - | pF |
| C_{oss} | Output Capacitance | | - | 300 | - | |
| C_{rss} | Reverse Transfer Capacitance | | - | 180 | - | |
| $t_{\text{d(ON)}}$ | Turn-on Delay Time | $V_{\text{GS}}=10\text{V}, V_{\text{DS}}=20\text{V}$, $I_{\text{D}}=1\text{A}, R_{\text{GEN}}=6\Omega$ | - | 28 | - | nS |
| t_{r} | Turn-on Rise Time | | - | 22 | - | |
| $t_{\text{d(OFF)}}$ | Turn-off Delay Time | | - | 39 | - | |
| t_{f} | Turn-off Fall Time | | - | 20 | - | |
| Q_{g} | Total Gate Charge | $V_{\text{GS}}=6\text{V}, V_{\text{DS}}=25\text{V}$ $I_{\text{D}}=14\text{A}$ | - | 34 | - | nC |
| Q_{g} | Total Gate Charge | $V_{\text{GS}}=10\text{V}, V_{\text{DS}}=25\text{V}$, $I_{\text{D}}=14\text{A}$ | - | 53 | - | |
| Q_{gs} | Gate-Source Charge | | - | 12 | - | |
| Q_{gd} | Gate-Drain Charge | | - | 16 | - | |
| Source-Drain Characteristics | | | | | | |
| $V_{\text{SD}}^{\circledast}$ | Diode Forward Voltage | $I_{\text{SD}}=10\text{A}$, $V_{\text{GS}}=0\text{V}$ | - | 0.8 | 1.1 | V |
| t_{rr} | Reverse Recovery Time | $I_{\text{F}}=10\text{A}$, $V_{\text{R}}=0\text{V}$ | - | 19 | - | nS |
| Q_{rr} | Reverse Recovery Charge | $dI_{\text{F}}/dt=100\text{A}/\mu\text{s}$ | - | 10.5 | - | nC |

Note ④ : Pulse test (pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$).

Note ⑤ : Guaranteed by design, not subject to production testing.

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N-Channel Typical Characteristics

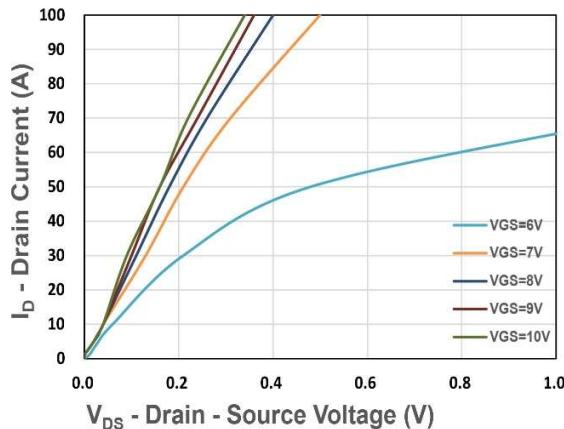


Figure 1. Output Characteristics

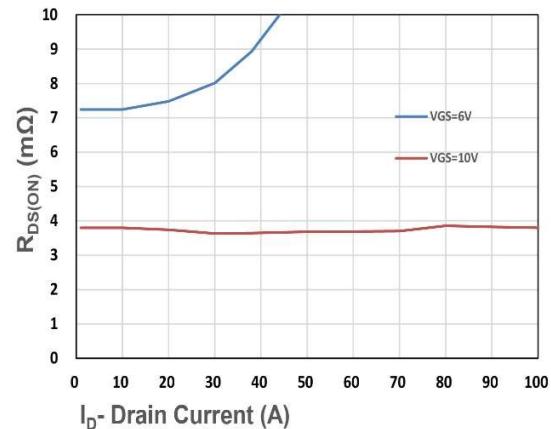


Figure 2. On-Resistance vs. ID

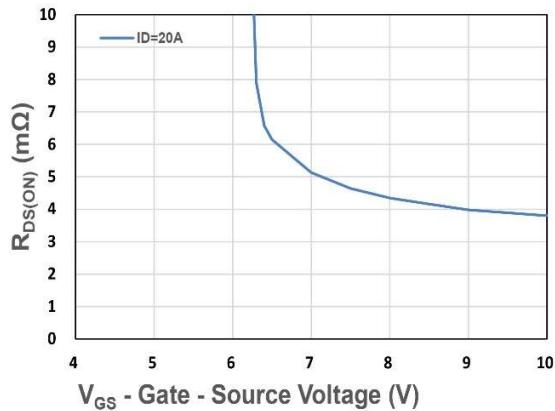


Figure 3. On-Resistance vs. VGS

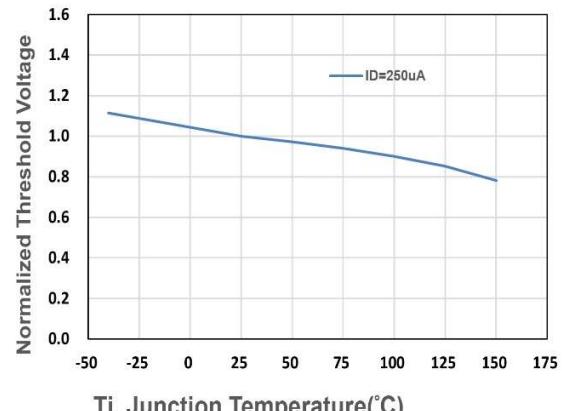


Figure 4. Gate Threshold Voltage

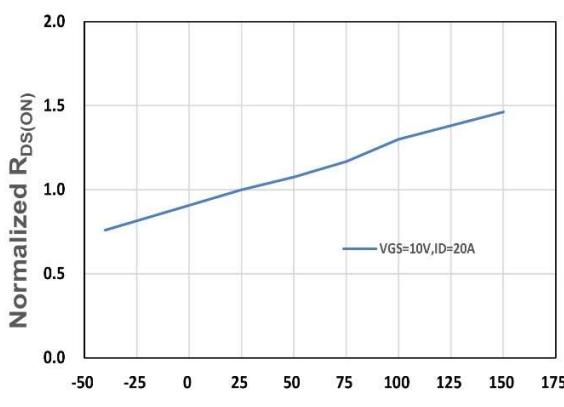


Figure 5. Drain-Source On Resistance

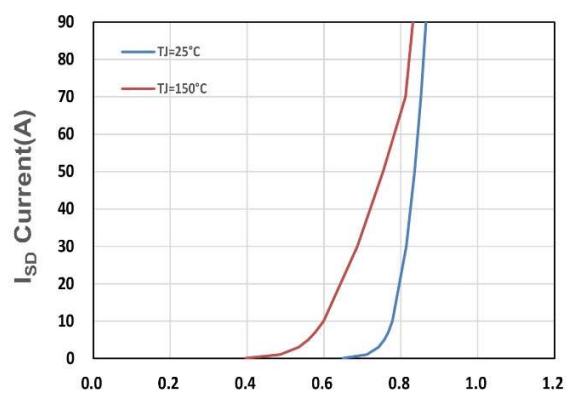


Figure 6. Source-Drain Diode Forward

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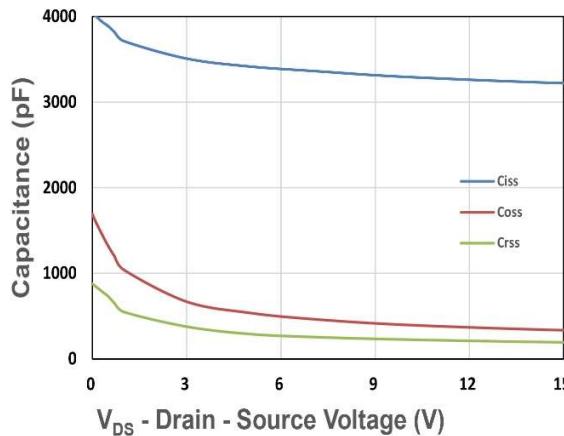


Figure 7. Capacitance

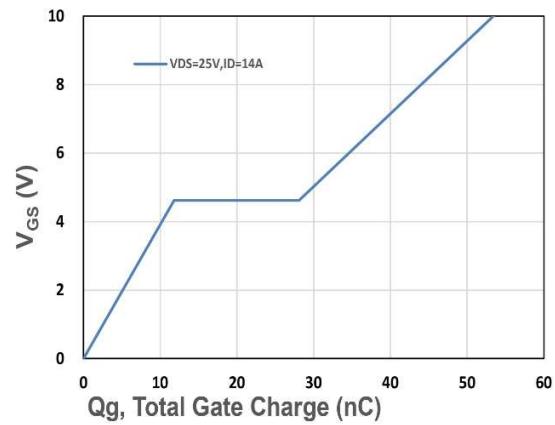


Figure 8. Gate Charge Characteristics

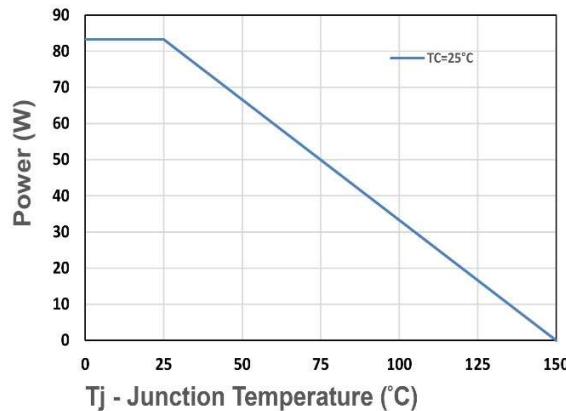


Figure 9. Power Dissipation

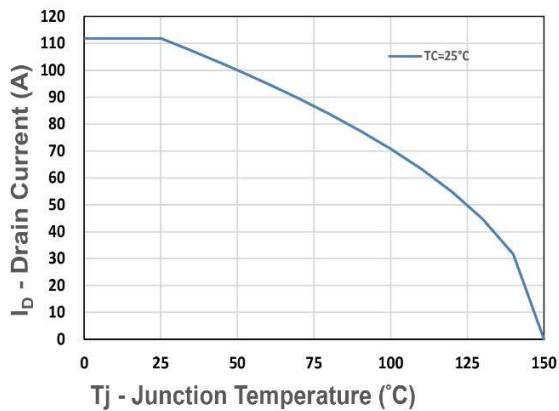


Figure 10. Drain Current

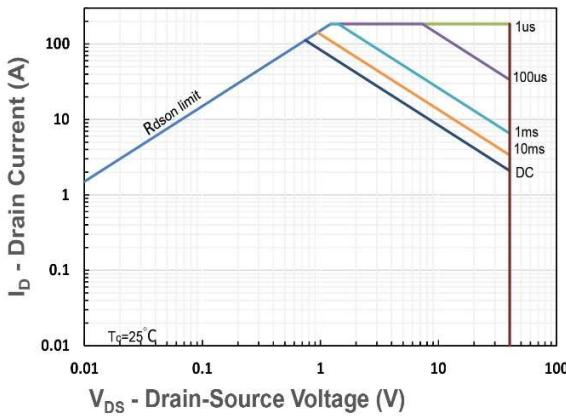


Figure 11. Safe Operating Area

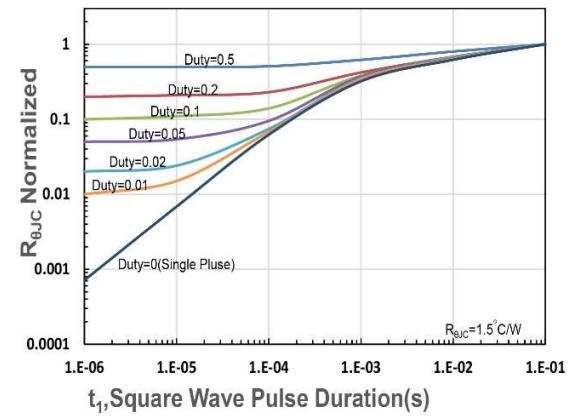


Figure 12. R_{euc} Transient Thermal Impedance